Docket No.: 005916 USA/FPS/MMCS/MC

PATENT/OFFICIAL

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Young Joseph PAIK

Serial No. 09/998,384

Group Art Unit: 2812

Filed: November 30, 2001

: Examiner:

For:

FEEDFORWARD AND FEEDBACK CONTROL FOR CONDITIONING OF

CHEMICAL MECHANICAL POLISHING PAD

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

This submission does not constitute a representation that a search has been made or that no better art exists and does not constitute an admission or representation that any of the listed documents is material or constitutes prior art. If it should be determined that any of the listed documents does not constitute prior art under the United States law, Applicants reserve the right

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to present to the Office the relevant facts and law regarding the appropriate status of such document.

No certification or fee is believed to be required. However, the Commissioner is hereby authorized to charge any additional fees should any be required for this submission, or credit any overpayment to deposit account no. 08-0219.

Respectfully submitted,

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Date: 0/4/03

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INFORMATION DISCLOSURE				ATTY. DOCKET NO. 005916 USA/FPS/MMCS/MC		SERIAL NO. 09/998,384		
	CITATION	IN AN			-			
APPLICATION								
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EXAMINER'S	T					T	FILING	DATE
INITIALS	PATENT NO.	DATE	NAME		CLASS	SUBCLASS		
	5,901,313	05/04/99	Wolf et al.				09/02/	97
	6,002,989	12/14/99	Shiba et al.		·		04/01/	97
	6,094,688	07/25/00	Mellen-Garnett	et al.			03/12/	98
	6,340,602	01/22/02	Johnson et al.				02/12/	01
	6,345,288	02/05/02	Reed et al.				05/15/00	
	6,368,879	04/09/02	Toprac				09/22/99	
	US- 2002/0107604	08/08/02	Riley et al.			12/06/00		00
	6,470,230	10/22/02	Toprac et al.				01/04/00	
	6,482,660	11/19/02	19/02 Conchieri et al.				03/19/01	
	6,567,717 05/20/03 Krivokapid		Krivokapic et a	ıl.		01/19/00		00
	×	FOR	EIGN PATENT	DOCUMENTS				
EXAMINER'S INITIALS	PATENT NO.	DATE	CO	UNTRY	CLASS	SUBCLASS	Translation	
	TAILMINO.	DAIL		CEAS		SOBCE ISS	Yes	No
	WO 99/59200	11/18/99	WIPO				X	
	WO 01/52319	07/19/01	WIPO				X	
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	ОТНЕ	R ART (Inclu	ding Author, Ti	tle, Date, Pertinent	Pages, Et	c.)	- 1	·
	Shanthikumar. Oct	ober 1999. "C nference Proc	Optimized Sample	nahan, Raman Nurar Planning for Wafer EE International Syn	Defect In:	spection," Sem	iconduc	tor
	23 July 2003. Invitation to Pay Additional Fees and Communication Relating to the Results of the International Search for PCT/US02/19116.							
	01 August 2003. Written Opinion for PCT/US01/27406.							
	20 August 2003. V	Written Opinio						
EXAMINER	DATE CONSIDERED							

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.